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How to Describe and Propagate Uncertainty When Processing Time Series: Metrological and Computational Challenges, with Potential Applications to Environmental Studies

Christian Servin, Martine Ceberio, Aline Jaimes, Craig Tweedie, and Vladik Kreinovich

Abstract Time series comes from measurements, and often, measurement inaccuracy needs to be taken into account, especially in such volatile application areas as meteorology and economics. Traditionally, when we deal with an individual measurement or with a sample of measurement results, we subdivide a measurement error into random and systematic components: systematic error does not change from measurement to measurement while random errors corresponding to different measurements are independent. In time series, when we measure the same quantity at different times, we can also have correlation between measurement errors corresponding to nearby moments of time. To capture this correlation, environmental science researchers proposed to consider the third type of measurement errors: periodic. This extended classification of measurement error may seem ad hoc at first glance, but it leads to a good description of the actual errors. In this paper, we provide a theoretical explanation for this semi-empirical classification, and we show how to efficiently propagate all types of uncertainty via computations.

1 Formulation of the Problem

In many applications areas – e.g., in meteorology, in financial analysis – the value of the important variable (temperature, stock price, etc.) changes with time. In order to adequately predict the corresponding value, we need to analyze the observed time series and to make a prediction based on this analysis; see, e.g., [3, 20].

All the values that form the time series come from measurements or from expert estimates. Neither measurements nor expert estimates are 100% accurate, especially in such volatile application areas as meteorology and economics. Thus, the actual values of the corresponding variables are, in general, slightly different from

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the observed values x_t . These measurement uncertainties affects the result of data processing.

For example, in meteorological and environmental applications, we measure, at different locations, temperature, humidity, wind speed and direction, flows of carbon dioxide and water between the soil and atmosphere, intensity of the sunlight, reflectivity of the plants, plant surface, etc. Based on these *local* measurement results, we estimate the *regional* characteristics such as the carbon fluxes describing the region as a whole – and then use these estimates for predictions. These predictions range from short-term meteorological predictions of weather to short-term environmental predictions of the distribution and survival of different ecosystems and species to long-term predictions of climate change; see, e.g., [1, 12]. Many of these quantities are difficult to measure accurately: for example, the random effects of turbulence and the resulting rapidly changing wind speeds and directions strongly affect our ability to accurately measure carbon dioxide and water flows; see, e.g., [18]. The resulting measurement inaccuracy is one of the main reasons why it is difficult to forecast meteorological, ecological, and climatological phenomena.

It is therefore desirable to describe how the corresponding measurement uncertainty affects the result of data processing. In this paper, we analyze this problem, describe the related challenges, and show how these challenges can be overcome.

2 Traditional Approach to Measurement Errors

When we are interested in the value x of some quantity that we can measure directly, we apply an appropriate measuring instrument and get the measurement result \tilde{x} . In the ideal world, the measurement result \tilde{x} is exactly equal to the desired value x . In practice, however, there is noise, there are imperfection, there are other factors which influence the measurement result. As a consequence, the measurement result \tilde{x} is, in general, different from the actual (unknown) value x of the quantity of interest, and the *measurement error* $\Delta x \stackrel{\text{def}}{=} \tilde{x} - x$ is different from 0.

Because of this, if we repeatedly measure the same quantity by the same measuring instrument, we get, in general, slightly different results. Some of these results are more frequent, some less frequent. For each interval of possible values, we can find the frequency with which the measurement result gets into this interval; at first, some of these frequencies change a lot with each new measurement, but eventually, once we have a large number of measurements, these frequencies stabilize – and become *probabilities* of different values of \tilde{x} and, correspondingly, probabilities of different values of measurement error Δx . In other words, the measurement error becomes a *random variable*.

Usually, it is assumed that random variables corresponding to different measurement errors are statistically independent from each other. In statistics, independence of two events A and B means that the probability of A does not depend on B , i.e., that the conditional probability $P(A|B)$ of A under condition B is equal to the unconditional probability $P(A)$ of the event A .

The probability $P(A)$ of the event A can be estimated as the ratio $\frac{N(A)}{N}$ of the number of cases $N(A)$ when the event A occurred to the total number N of observed cases. Similarly, the probability $P(B)$ of the event B can be estimated as the ratio $\frac{N(B)}{N}$ of the number of cases $N(B)$ when the event A occurred to the total number N of observed cases, and the probability $P(A \& B)$ of both events A and B can be estimated as the ratio $\frac{N(A \& B)}{N}$ of the number of cases $N(A \& B)$ when both events A and B occurred to the total number N of observed cases. In contrast, to estimate the conditional probability of A given B , we must only take into account cases when B was observed. As a result, we get an estimate $P(A|B) \approx \frac{N(A \& B)}{N(B)}$. Since $P(A \& B) \approx \frac{N(A \& B)}{N}$ and $P(B) \approx \frac{N(B)}{N}$, we conclude that $N(A \& B) \approx P(A \& B) \cdot N$ and $N(B) \approx P(B) \cdot N$ and therefore, $P(A|B) \approx \frac{P(A \& B) \cdot N}{P(B) \cdot N} = \frac{P(A \& B)}{P(B)}$, so $P(A|B) \approx \frac{P(A \& B)}{P(B)}$. The larger the sample, the more accurate are these estimates, so in the limit when N tends to infinity, we get the equality $P(A|B) = \frac{P(A \& B)}{P(B)}$, i.e., equivalently, $P(A \& B) = P(A|B) \cdot P(B)$. For independent events, $P(A|B) = P(A)$ and thus, $P(A \& B) = P(A) \cdot P(B)$.

So, under the independence assumption, if we have two different series of measurements, resulting in measurement errors Δx and Δy , then the probability $P(\Delta x \in [\underline{x}, \bar{x}] \& \Delta y \in [\underline{y}, \bar{y}])$ that Δx is in an interval $[\underline{x}, \bar{x}]$ and Δy is in an interval $[\underline{y}, \bar{y}]$ is equal to the product of the two probabilities:

- the probability $P(\Delta x \in [\underline{x}, \bar{x}])$ that Δx is in the interval $[\underline{x}, \bar{x}]$, and
- the probability $P(\Delta y \in [\underline{y}, \bar{y}])$ that Δy is in the interval $[\underline{y}, \bar{y}]$:

$$P(\Delta x \in [\underline{x}, \bar{x}] \& \Delta y \in [\underline{y}, \bar{y}]) = P(\Delta x \in [\underline{x}, \bar{x}]) \cdot P(\Delta y \in [\underline{y}, \bar{y}]).$$

Usually in metrology, the measurement error is divided into two components (see, e.g., [16]):

- the *systematic* error component, which is defined as the expected value (mean) $E(\Delta x)$ of the measurement errors, and
- the *random* error component which is defined as the difference $\Delta x - E(\Delta x)$ between the measurement error Δx and its systematic component $E(\Delta x)$.

Systematic error component is usually described by the upper bound Δ_s on its absolute value: $|E(\Delta x)| \leq \Delta_s$, while the random error is usually described by its mean square value

$$\sigma = \sqrt{E[(\Delta x - E(\Delta x))^2]}.$$

In statistical terms, $\sigma = \sqrt{V}$ is the *standard deviation* of the random variable Δx , i.e., the square root of the *variance* $V = E[(\Delta x - E(\Delta x))^2]$.

The practical meaning of these components – and the practical difference between them – can be described if, in order to improve measurement accuracy, we repeatedly measure the same quantity several times. Once we have several results

$\tilde{x}^{(1)}, \dots, \tilde{x}^{(M)}$ of measuring the same (unknown) quantity x , we can then take the arithmetic average

$$\tilde{x} = \frac{\tilde{x}^{(1)} + \dots + \tilde{x}^{(M)}}{M}$$

as the new estimate.

One can easily see that the measurement error $\Delta x = \tilde{x} - x$ corresponding to this new estimate is equal to the average of the measurement errors $\Delta x^{(k)} = \tilde{x}^{(k)} - x$ corresponding to individual measurements:

$$\Delta x = \frac{\Delta x^{(1)} + \dots + \Delta x^{(M)}}{M}.$$

What are the systematic and random error components of this estimate? Let us start with the systematic error component, i.e., in mathematical terms, with the mean. It is known that the mean of the sum is equal to the sum of the means, and that when we divide a random variable by a constant, its mean is divided by the same constant. All M measurements are performed by the same measuring instrument with the same systematic error $E(\Delta x^{(1)}) = \dots = E(\Delta x^{(M)})$. Thus, for the sum $\Delta x^{(1)} + \dots + \Delta x^{(M)}$, the mean is equal to

$$E(\Delta x^{(1)} + \dots + \Delta x^{(M)}) = E(\Delta x^{(1)}) + \dots + E(\Delta x^{(M)}) = M \cdot E(\Delta x^{(k)}).$$

Therefore, the mean of the ratio Δx (which is obtained by dividing the above sum by M) is M times smaller than the mean of the sum, i.e., equal to $E(\Delta x) = E(\Delta x^{(k)})$. In other words, the systematic error component does not decrease if we simply repeat the measurements.

In contrast, the random component decreases, or, to be precise, its standard deviation decreases. Indeed, for independent random variables, the variance of the sum is equal to the sum of the variances, and when we divide a random variable by a constant, the variance is divided by the square of this constant. The variance $V = \sigma^2$ of each random error component is equal to $V^{(1)} = \dots = V^{(M)}$; thus, the variance of the sum $\Delta x^{(1)} + \dots + \Delta x^{(M)}$ is equal to the sum of these variances, i.e., to

$$V[\Delta x^{(1)} + \dots + \Delta x^{(M)}] = V^{(1)} + \dots + V^{(M)} = M \cdot (\sigma^{(k)})^2.$$

Therefore, the variance of the ratio Δx (which is obtained by dividing the above sum

by M) is M^2 times smaller than the variance of the sum, i.e., equal to $\frac{(\sigma^{(k)})^2}{M}$. So,

the standard deviation σ (which is the square root of this variance) is equal to $\frac{\sigma^{(k)}}{\sqrt{M}}$.

In other words, the more times we repeat the measurement, the smaller the resulting random error.

So, when we repeat the same measurement several times, the random error disappears, and the only remaining error component is the systematic error.

3 The Traditional Metrological Approach Does Not Work Well for Time Series

In the traditional approach, we represent the measurement error as the sum of two components:

- a *systematic* component which is *the same* for all measurements, and
- a *random* component which is *independent* for different measurements.

When we process time series, this decomposition is insufficient: e.g., usually, there are strong correlations between measurement errors corresponding to consequent measurements.

To achieve a better representation of measurement errors, researchers in environmental science have proposed a semi-empirical idea of introducing the third component of measurement error: the *seasonal (periodic)* component; see, e.g., [14].

For example, a seasonal error component can represent errors that only happen in spring (this is where the name of this error component comes from), or errors that only happen at night, etc.

From the purely mathematical viewpoint, we can have periodic error components corresponding to all possible frequencies. However, from the physical viewpoint, it makes sense to concentrate on the components with physically meaningful frequencies – and with frequencies which are multiples of these frequencies, e.g., double or triple the daily or yearly frequencies.

For example, in environmental observations, it makes sense to concentrate on daily and yearly periodic errors. If we are interested in the effect of human activity, then we need to add weekly errors – since human activity periodically changes from weekdays to weekends.

The idea of using three components of measurement error works extremely well – which leads to two related challenges:

- A *metrological* challenge: how can we explain this success? What is the foundation of this idea?
- A *computational* challenge: how can we efficiently describe this new error component and how can we efficiently propagate it through computations?

In this paper, we address both challenges:

- we provide a theoretical justification for the semi-heuristic idea of the third error component, and
- we show a natural way for efficiently describing this error component, and show how to efficiently propagate different error components through computations.

4 First Result: A Theoretical Explanation of the Three-Component Model of Measurement Error

Our objective is to analyze measurement errors $\Delta x(t)$ corresponding to time series. Namely, we want to represent a generic measurement error as a linear combination of several error components.

This division into components can be described on different levels of granularity. Let us consider the level where the granules are the smallest, i.e., where each granule corresponds to a finite-dimensional linear space, i.e., to the linear space whose elements can be determined by finitely many parameters.

Each component of the measurement error is thus described by a finite-dimensional linear space L , i.e., by the set of all the functions of the type $x(t) = c_1 \cdot x_1(t) + \dots + c_n \cdot x_n(t)$, where $x_1(t), \dots, x_n(t)$ are given functions, and c_1, \dots, c_n are arbitrary constants.

In most applications, observed signals continuously (and even smoothly) depend on time, so we will assume that all the functions $x_i(t)$ are smooth (differentiable).

Also, usually, there is an upper bound on the measurement error, so we will assume that each of the functions $x_i(t)$ are bounded by a constant.

Finally, for a long series of observations, we can choose a starting point arbitrarily. If instead of the original starting point, we take a starting point which is t_0 seconds earlier, then each moment of time which was originally described as moment t is not described as moment $t + t_0$. Then, for describing measurement errors, instead of the original function $x(t)$, we have a new function $x_{t_0}(t)$ for which $x_{t_0}(t + t_0) = x(t + t_0)$. It is reasonable to require that the linear space that describes a component of the measurement error does not change simply because we changed the starting point. Thus, we arrive at the following definitions.

Definition 1. We say that a function $x(t)$ of one variable is *bounded* if there exists a constant M for which $|x(t)| \leq M$ for all t .

Definition 2. We say that a class F of functions of one variable is *shift-invariant* if for every function $x(t) \in F$ and for every real number t_0 , the function $x(t + t_0)$ also belongs to the class F .

Definition 3. By an *error component* we mean a shift-invariant finite-dimensional linear space of functions

$$L = \{c_1 \cdot x_1(t) + \dots + c_n \cdot x_n(t)\},$$

where $x_1(t), \dots, x_n(t)$ are given bounded smooth functions and c_i are arbitrary numbers.

Theorem 1. Every error component is a linear combination of the functions

$$x(t) = \sin(\omega \cdot t) \text{ and } x(t) = \cos(\omega \cdot t).$$

Proof.

1°. Let us first use the assumption that the linear space L is shift-invariant.

For every i from 1 to n , the corresponding function $x_i(t)$ belongs to the linear space L . Since the error component is shift-invariant, we can conclude that for every real number t_0 , the function $x_i(t+t_0)$ also belongs to the same linear space. Thus, for every i from 1 to n and for every t_0 , there exist values c_1, \dots, c_n (possibly depending on i and on t_0) for which

$$x_i(t+t_0) = c_{i1}(t_0) \cdot x_1(t) + \dots + c_{in}(t_0) \cdot x_n(t). \quad (1)$$

2°. We know that the functions $x_1(t), \dots, x_n(t)$ are smooth. Let us use the equation (1) to prove that the functions $c_{ij}(t_0)$ are also smooth (differentiable).

Indeed, if we substitute n different values t_1, \dots, t_n into the equation (1), then we get a system of n linear equations with n unknowns to determine n values $c_{i1}(t_0), \dots, c_{in}(t_0)$:

$$x_i(t_1+t_0) = c_{i1}(t_0) \cdot x_1(t_1) + \dots + c_{in}(t_0) \cdot x_n(t_1);$$

...

$$x_i(t_n+t_0) = c_{i1}(t_0) \cdot x_1(t_n) + \dots + c_{in}(t_0) \cdot x_n(t_n).$$

The solution of a system of linear equations – as determined by the Cramer's rule – is a smooth function of all the coefficients and right-hand sides. Since all the right-hand sides $x_i(t_j+t_0)$ are smooth functions of t_0 and since all the coefficients $x_i(t_j)$ are constants (and thus, are also smooth), we conclude that each dependence $c_{ij}(t_0)$ is indeed smooth.

3°. Now that we know that all the functions $x_i(t)$ and $c_{ij}(t_0)$ are differentiable, we can differentiate both sides of the equation (1) with respect to t_0 and then take $t_0 = 0$. As a result, we get the following systems of n differential equations with n unknown functions $x_1(t), \dots, x_n(t)$:

$$\dot{x}_i(t) = c_{i1} \cdot x_1(t) + \dots + c_{in} \cdot x_n(t),$$

where $\dot{x}_i(t)$ denotes derivative over time, and c_{ij} denoted the value of the corresponding derivative \dot{c}_{ij} when $t_0 = 0$.

3°. We have shown that the functions $x_1(t), \dots, x_n(t)$ satisfy a system of linear differential equations with constant coefficients.

It is known that a general solution of such system of equations is a linear combination of functions of the type $t^k \cdot \exp(\lambda \cdot t)$, where k is a natural number (non-negative integer), and λ is a complex number. Specifically, λ is an eigenvalue of the matrix c_{ij} , and the value $k > 0$ appears when we have a degenerate eigenvalue, i.e., an eigenvalue for which there are several linearly independent eigenvectors.

4°. Every complex number λ has the form $a + i \cdot \omega$, where a is its real part and ω is its imaginary part. So:

$$\exp(\lambda \cdot t) = \exp(a \cdot t) \cdot \cos(\omega \cdot t) + i \cdot \exp(a \cdot t) \cdot \sin(\omega \cdot t).$$

Thus, every function $x_i(t)$ can be represented as a linear combination of expressions of the types $t^k \cdot \exp(a \cdot t) \cdot \cos(\omega \cdot t)$ and $t^k \cdot \exp(a \cdot t) \cdot \sin(\omega \cdot t)$.

5°. Now, we can use the requirement that the functions $x_i(t)$ are bounded.

5.1°. Because of this requirement, we cannot have $a \neq 0$:

- for $a > 0$, the function is unbounded for $t \rightarrow +\infty$, while
- for $a < 0$, the function is unbounded for $t \rightarrow -\infty$.

So, we must have $a = 0$.

5.2°. Similarly, if $k > 0$, the corresponding function is unbounded. Thus, we must have $k = 0$.

6°. Thus, every function $x_i(t)$ is a linear combination of the trigonometric functions $x(t) = \sin(\omega \cdot t)$ and $x(t) = \cos(\omega \cdot t)$.

The theorem is proven.

What are the practical conclusions of this result? We have concluded that the measurement error $\Delta x(t)$ can be described as a linear combination of sines and cosines corresponding to different frequencies ω .

In practice, depending on the relation between the frequency ω and the frequency f with which we perform measurements, we can distinguish between small, medium, and large frequencies:

- frequencies ω for which $\omega \ll f$ are *small*;
- frequencies ω for which $\omega \gg f$ are *large*, and
- all other frequencies ω are medium.

Let us consider these three types of frequencies one by one.

When the frequency ω is low, the corresponding values $\cos(\omega \cdot t)$ and $\sin(\omega \cdot t)$ practically do not change with time: the change period is much larger than the usual observation period.

Thus, we can identify low-frequency components with *systematic* error component – the error component that practically does not change with time.

When the frequency ω is high, $\omega \gg f$, the phases of the values $\cos(\omega \cdot t_i)$ and $\cos(\omega \cdot t_{i+1})$ (or, alternatively, $\sin(\omega \cdot t_i)$ and $\sin(\omega \cdot t_{i+1})$) corresponding to the two sequential measurements t_i and t_{i+1} differ so much that for all practical purposes, the resulting values of cosine or sine functions are independent.

Thus, high-frequency components can be identified with *random* error component – the error component for which measurement errors corresponding to different measurements are independent.

In contrast to the cases of low and high frequencies, where the periodicity of the corresponding cosine and sine functions is difficult to observe, components $\cos(\omega \cdot t)$ and $\sin(\omega \cdot t)$ corresponding to medium frequencies ω are observably periodic.

It is therefore reasonable to identify medium-frequency error components with *seasonal (periodic)* components of the measurement error.

This conclusion explains why, in addition to the original physically meaningful frequencies, it is also reasonable to consider their multiples:

- We know that the corresponding error component is a periodic function of time, with the physically meaningful period T_0 .
- It is known that every periodic function can be explained into Fourier series, i.e., represented as a linear combination of sines and cosines with frequencies ω which are multiples of the basic frequency $\omega_0 = \frac{2\pi}{T_0}$ corresponding to the period T_0 .

Thus, we have indeed provided a justification to the semi-empirical three-component model of measurement error.

5 Periodic Error Component: Technical Details

In the above section, we explained that the periodic error component is as fundamental as the more traditional systematic and random error components. It is therefore necessary to extend the usual analysis of error components and their propagation to this new type of measurement errors.

For systematic and random error components we know:

- how to describe reasonable bounds on this error component, and
- how to estimate this error component when we calibrate the measuring instrument.

Specifically, the random error component is characterized by its standard deviation σ , while a systematic error component s is characterized by the upper bound Δ : $|s| \leq \Delta$.

The standard deviation σ of the measuring instrument can be estimated if we repeatedly measure the same quantity x by this instrument. Then, the desired standard deviation can be estimated as the sample standard deviation of the corresponding measurement results $\tilde{x}^{(1)}, \dots, \tilde{x}^{(M)}$:

$$\sigma \approx \sqrt{\frac{1}{M} \cdot \sum_{k=1}^M (\tilde{x}^{(k)} - E)^2},$$

where $E = \frac{1}{M} \cdot \sum_{k=1}^M \tilde{x}^{(k)}$.

To estimate the systematic error component, it is not enough to have the given measuring instrument, we also need to *calibrate* the measuring instrument, i.e., to measure the same quantity x with an additional much more accurate (“standard”) measuring instrument – whose measurement result \tilde{x}_s is assumed to be very close

to the actual value x of the measured quantity. Here, $E \approx E(\tilde{x})$ and $\tilde{x}_s \approx x$, so the difference $E - x_s$ is approximately equal to $E(\tilde{x}) - x = E(\tilde{x} - x) = E(\Delta x)$. Thus, this difference $E - \tilde{x}_s$ can be used as a good approximation to the systematic error component.

Since we want to also take into account the periodic error component, it is desirable to provide answers to the above two questions for the periodic error component as well.

How can we describe reasonable bounds for each part of the periodic error component? For each frequency ω , the corresponding linear combination

$$a_c \cdot \cos(\omega \cdot t) + a_s \cdot \sin(\omega \cdot t)$$

can be equivalently represented as $A \cdot \cos(\omega \cdot t + \varphi)$. This is the form that we will use for describing the periodic error component.

Similarly to the systematic error, for the amplitude A , we will assume that we know the upper bound P : $|A| \leq P$.

For phase φ , it is natural to impose a requirement that the probability distribution of phase be invariant with respect to shift $t \rightarrow t + t_0$. When time is thus shifted, the phase is also shifted by $\varphi_0 = \omega \cdot t_0$. Thus, the requirement leads to the conclusion that the probability distribution for the phase be shift-invariant, i.e., that the corresponding probability density function $\rho(\varphi)$ is shift-invariant $\rho(\varphi) = \rho(\varphi + \varphi_0)$ for every possible shift φ_0 . This means that this probability density function must be constant, i.e., that the phase φ is uniformly distributed on the interval $[0, 2\pi]$.

How can we estimate the periodic error component when calibrating a measuring instrument? When we compare the results of measuring the time series by our measuring instrument and by a standard measuring instrument, we get a sequence of differences $\tilde{x}(t) - \tilde{x}_s(t)$ that approximates the actual measurement errors $\Delta x(t)$.

Periodic error components are sinusoidal components corresponding to several frequencies. In data processing, there is a known procedure for representing each sequence as a linear combination of sinusoids of different frequency – Fourier transform. To find the periodic components, it is therefore reasonable to perform a Fourier Transform; the amplitudes of the Fourier transform corresponding to physically meaningful frequencies (and their multiples) ω will then serve as estimates for the amplitude of the corresponding periodic measurement error component.

Computing Fourier transform is fast: there is a known Fast Fourier Transform (FFT) algorithm for this computation; see, e.g., [2].

In this process, there is still a computational challenge. Indeed, while the standard measuring instrument is reasonably accurate and its measurement results $\tilde{x}_s(t)$ provide a good approximation to the actual values $x(t)$, these results are still somewhat different from the actual values $x(t)$. Hence, the observed differences $\tilde{x}(t) - \tilde{x}_s(t)$ are only approximately equal to the measurement errors $\Delta x(t) = \tilde{x}(t) - x(t)$. When we apply FFT in a straightforward way, this approximation error sometimes leads to drastic over-estimation of the results; see, e.g., [4, 13]. Because of this fact, many researchers replaced FFT by much slower – but more accurate – error estimation algorithms.

In our paper [13], we showed how we can modify the FFT techniques so that we get (almost) exact error bounds while being (almost) as fast as the original FFT. So, to estimate the periodic error component, we need to use thus modified FFT algorithm.

6 Because of Our Justification, the Three-Component Model of Approximation Error Can Also Be Applied to Expert Estimates

In many practical situations, the measurement results are not sufficient to make reasonable conclusions. We need to supplement measurement results with the knowledge of experts. The use of expert knowledge in processing data is one of the important aspects of *computational intelligence*.

For example, when a medical doctor makes a diagnosis and/or prescribes medicine, he or she is usually not following an algorithm that inputs the patients stats and outputs the name of the disease and the dosage of the corresponding medicine. If medicine was that straightforward, there would have been no need for skilled medical doctors. A good doctor also uses his/her experience, his/her intuition. Similarly, in environmental research, we *measure* temperature, humidity, etc. However, to make meaningful conclusions, it is necessary to supplement these measurement results with *expert estimates* of, e.g., amount of leaves on the bushes (“low”, “medium”, “high”), state of the leaves – and many other characteristics which are difficult to measure but which can be easily estimated by an expert.

We have mentioned that in data processing, it is important to take into account the uncertainty of measurement results. Expert estimates are usually even much less accurate than measurement results. So, it is even more important to take into account the uncertainty of expert estimates.

The main idea behind most methods for dealing with uncertainty of expert estimates is to treat an expert as a measuring instrument and use the corresponding metrological techniques.

One of the main techniques for describing expert uncertainty is *fuzzy techniques*; see, e.g., [9, 15]. While these techniques are not exactly probabilistic, many fuzzy techniques are similar to the probabilistic ones.

For example, one of the most widely used methods of determining the (fuzzy) degree of belief $\mu_P(x)$ that a certain value x satisfies the property P (e.g., that a certain temperature is low) is to poll several experts and take, as $\mu_P(x)$, the proportion of those who think that x satisfies this property.

Good news is that in our analysis of the error components, we never used the fact that this error comes from measurements. We can therefore apply the exact same analysis to the approximation error of the expert estimates.

Thus, while our main current emphasis is on measurement results and measurement uncertainty, it is desirable to apply the same three-component decomposition to inaccuracies of expert estimates as well.

7 How to Propagate Uncertainty in the Three-Component Model

In the previous sections, we analyzed how to *describe* the uncertainty related to measurements and/or expert estimates. Some quantities can be indeed directly measured or estimates. However, there are many quantities of interest which cannot be directly measured or estimated.

An example of such a quantity is a carbon flux that describes the exchange of carbon between the soil and the atmosphere; see, e.g., [12]. It is difficult to measure this flux directly. Instead, we measure the humidity, wind and concentration of different gases at different height of a special meteorological tower, and then use the results of these measurements to process the data.

In general, for many quantities y , it is not easy (or even impossible) to measure them directly. Instead, we measure related quantities x_1, \dots, x_n , and use the known relation $y = f(x_1, \dots, x_n)$ between x_i and y to estimate the desired quantity y .

Since measurements come with uncertainty, the resulting estimate is, in general, somewhat different from the actual value of the desired quantity – even when the relation $y = f(x_1, \dots, x_n)$ is known exactly. It is therefore desirable to *propagate* this uncertainty, i.e., to find out how accurate is the estimate based on (approximate) measurement results.

In practical applications, many inputs to the data processing algorithm come from the same sensor at different moments of time. In other words, as inputs, we have the results $\tilde{x}_i(t_{ij})$ of measuring the values $x_i(t_{ij})$ by the i -th sensor at the j -th moment of time $t_{ij} = t_0 + j \cdot \Delta t_i$, where t_0 is the starting moment of all the measurements, and Δt_i is the time interval between the two consecutive measurements performed by the i -th sensor.

The desired quantity y depends on all these values:

$$y = f(x_1(t_{11}), x_1(t_{12}), \dots, x_2(t_{21}), x_2(t_{22}), \dots, x_n(t_{n1}), x_n(t_{n2}), \dots).$$

Instead of the actual values $x_i(t_{ij})$, we only know the measurement results $\tilde{x}_i(t_{ij})$, results which differ from the actual values by the corresponding measurement errors $\Delta x_i(t_{ij})$:

$$\tilde{x}_i(t_{ij}) = x_i(t_{ij}) + \Delta x_i(t_{ij}).$$

After applying the data processing algorithm f to the measurement results $\tilde{x}_i(t_{ij})$, we get the estimate \tilde{y} for the desired quantity y :

$$\tilde{y} = f(\tilde{x}_1(t_{11}), \tilde{x}_1(t_{12}), \dots, \tilde{x}_n(t_{n1}), \tilde{x}_n(t_{n2}), \dots).$$

We are interested in estimating the difference

$$\Delta y = \tilde{y} - y = f(\tilde{x}_1(t_{11}), \tilde{x}_1(t_{12}), \dots, \tilde{x}_n(t_{n1}), \tilde{x}_n(t_{n2}), \dots) - f(x_1(t_{11}), x_1(t_{12}), \dots, x_n(t_{n1}), x_n(t_{n2}), \dots).$$

We know that the actual (unknown) value $x_i(t_{ij})$ of each measured quantity is equal to

$$x_i(t_{ij}) = \tilde{x}_i(t_{ij}) - \Delta x_i(t_{ij}).$$

Thus, the desired difference has the form

$$\begin{aligned} \Delta y = & f(\tilde{x}_1(t_{11}), \dots, \tilde{x}_n(t_{n1}), \tilde{x}_n(t_{n2}), \dots) - \\ & f(\tilde{x}_1(t_{11}) - \Delta x_1(t_{11}), \dots, \tilde{x}_n(t_{n1}) - \Delta x_n(t_{n1}), \tilde{x}_n(t_{n2}) - \Delta x_n(t_{n2}), \dots). \end{aligned}$$

Our objective is to estimate this difference based on the known information about the measurement errors $\Delta x_i(t_{ij})$.

Measurement errors are usually relatively small, so terms quadratic and of higher order in terms of $\Delta x_i(t_{ij})$ can be safely ignored.

For example, if the measurement error is 10%, its square is 1% which is much much smaller than 10%. If we measure with a higher accuracy, e.g., of 1%, then the square of this value is 0.01% which is even much more smaller than the error itself.

Thus, we can *linearize* the above formula, i.e., expand the dependence of Δy on $\Delta x_i(t_{ij})$ in Taylor series and keep only linear terms in this expansion. As a result, we arrive at the following formula:

$$\Delta y = \sum_i \sum_j C_{ij} \cdot \Delta x_i(t_{ij}),$$

where C_{ij} denotes the corresponding partial derivative $\frac{\partial y}{\partial x_i(t_{ij})}$.

As a result of this linearization, we can consider all three components separately. Indeed, we know that each measurement errors $\Delta x_i(t_{ij})$ consists of three components: systematic component s_i , random component r_{ij} , and periodic component(s) $A_{\ell i} \cdot \cos(\omega_\ell \cdot t_{ij} + \phi_{\ell i})$ corresponding to different physically meaningful frequencies (and their multiples) ω_ℓ :

$$\Delta x_i(t_{ij}) = s_i + r_{ij} + \sum_\ell A_{\ell i} \cdot \cos(\omega_\ell \cdot t_{ij} + \phi_{\ell i}).$$

The dependence of Δy on the measurement errors $\Delta x_i(t_{ij})$ is linear. Thus, we can represent Δy as the sum of different components coming from, correspondingly, systematic, random, and periodic errors:

$$\Delta y = \Delta y_s + \Delta y_r + \sum_\ell \Delta y_{p\ell},$$

where

$$\Delta y_s = \sum_i \sum_j C_{ij} \cdot s_i;$$

$$\Delta y_r = \sum_i \sum_j C_{ij} \cdot r_{ij};$$

$$\Delta y_{p\ell} = \sum_i \sum_j C_{ij} \cdot A_{\ell i} \cdot \cos(\omega_\ell \cdot t_{ij} + \phi_{\ell i}).$$

So, it is indeed sufficient to estimate the effect of all three types of measurement error components separately.

In these estimations, we will make a natural assumption: that measurement errors corresponding to different time series are independent. Indeed, as we have mentioned earlier,

- while measurement errors corresponding to measurement by the same sensor at consecutive moments of time are correlated,
- measurement errors corresponding to different sensors usually come from different factors and are, therefore, largely independent.

Because of this assumption, we arrive at the following algorithms for estimating different components of Δy .

Propagating random component is the traditional part of error propagation. A natural way to describe the resulting error Δy_r is to use simulations (i.e., a so-called Monte-Carlo approach).

By definition of the random error component, the values r_{ij} and r_{ik} corresponding to measurements by the same i -th sensor at different moments of time t_{ij} and t_{ik} are independent. We are also assuming that the values r_{ij} and $r_{i'j'}$ corresponding to different sensors are independent. Thus, all the values r_{ij} corresponding to different pairs (i, j) are independent.

There are many such values, since each sensor performs the measurements with a high frequency – e.g., one reading every second or every minute. The value Δy_r is thus a linear combination of a large number of independent random variables. It is known that under reasonable conditions, the probability distribution of such a combination tends to normal; this is what is known as the Central Limit Theorem – one of the main reasons why normal distributions are ubiquitous in nature; see, e.g., [19].

A normal distribution is uniquely determined by its mean and standard deviation. We know that each measurement error r_{ij} has mean 0 and a known standard deviation σ_i corresponding to measurements of the i -th sensor. The mean of the linear combination is equal to the linear combination of means. Thus, the mean of Δy_r is 0. The standard deviation can be obtained if we repeatedly simulate random errors and take a standard deviation of the corresponding empirical values $\Delta y_r^{(1)}, \Delta y_r^{(2)}, \dots$. Thus, we arrive at the following algorithm.

Propagating random component: algorithm. The random component Δy_r is normally distributed with zero mean. Its standard deviation can be obtained as follows:

- First, we apply the algorithm f to the measurement results $\tilde{x}_i(t_{ij})$ and get the estimate \tilde{y} .
- Then, for $k = 1, \dots, N$, we do the following:
 - simulate the random errors $r_{ij}^{(k)}$ as independent random variables (e.g., Gaussian) with 0 mean and standard deviation σ_i ;
 - form simulated values $x_i^{(k)}(t_{ij}) = \tilde{x}_i(t_{ij}) - r_{ij}^{(k)}$;

- substitute the simulated values $x_i^{(k)}(t_{ij})$ into the data processing algorithm f and get the result $y^{(k)}$.
- Finally, we estimate the standard deviation σ of the random component Δy_r as

$$\sigma = \sqrt{\frac{1}{N} \cdot \sum_{k=1}^N (y^{(k)} - \bar{y})^2}.$$

Mathematical comment. The proof that this algorithm produces a correct result easily follows from the fact that for simulated values, the difference $y^{(k)} - \bar{y}$ has the form $\sum_i \sum_j C_{ij} \cdot r_{ij}^{(k)}$ and thus, has the exact same distribution as $\Delta y_r = \sum_i \sum_j C_{ij} \cdot \Delta x_i(t_{ij})$; see, e.g., [10].

Metrological comment. In some practical situations, instead of the standard deviations $\sigma_i = \sqrt{E[(\Delta x)^2]}$ that describe the *absolute* accuracy, practitioners often describe *relative* accuracy δ_i such as 5% or 10%. In this case, the standard deviation σ_i can be obtained as $\sigma_i = \delta_i \cdot m_i$, i.e., by multiplying the given value δ_i and the mean square value of the signal

$$m_i = \sqrt{\frac{1}{T_i} \cdot \sum_j (\tilde{x}_i(t_{ij}))^2},$$

where T_i is the total number of measurements performed by the i -th sensor.

Let us now consider the problem of propagating systematic component. By definition, the systematic component Δy_s of the resulting error Δy is equal to $\Delta y_s = \sum_i \sum_j C_{ij} \cdot s_i$. If we combine terms corresponding to different j , we conclude that $\Delta y_s = \sum_i K_i \cdot s_i$, where $K_i \stackrel{\text{def}}{=} \sum_j C_{ij}$.

The values K_i can be explicitly described. Namely, one can easily see that if for some small value $\delta > 0$, for this sensor i , we take $\Delta x_i(t_{ij}) = \delta$ for all j , and for all other sensors i' , we take $\Delta x_{i'}(t_{i'j}) = 0$, then the resulting increase in y will be exactly equal to $\delta \cdot K_i$.

Once we have determined the coefficients K_i , we need to find out the smallest and the largest possible value of the sum $\Delta y_s = \sum_i K_i \cdot s_i$. Each parameter s_i can take any value between $-\Delta_{si}$ and Δ_{si} , and these parameters are independent. Thus, the sum is the largest when each term $K_i \cdot s_i$ is the largest.

Each term is a linear function of s_i . A linear function is increasing or decreasing depending on whether the coefficient K_i is positive or negative.

- When $K_i \geq 0$, the linear function $K_i \cdot s_i$ is increasing and thus, its largest possible value is attained when s_i attains its largest possible value Δ_{si} . Thus, this largest possible value is equal to $K_i \cdot \Delta_{si}$.

- When $K_i \leq 0$, the linear function $K_i \cdot s_i$ is decreasing and thus, its largest possible value is attained when s_i attains its smallest possible value $-\Delta_{si}$. Thus, this largest possible value is equal to $-K_i \cdot \Delta_{si}$.

In both cases, the largest possible value is equal to $|K_i| \cdot \Delta_{si}$ and thus, the largest possible value Δ_s of the sum Δy_s is equal to $\Delta_s \stackrel{\text{def}}{=} \sum_i |K_i| \cdot \Delta_{si}$. Similarly, one can prove that the smallest possible value of Δy_s is equal to $-\Delta_s$.

Thus, we arrive at the following algorithm for computing the upper bound Δ_s on the systematic component Δy_s .

Propagating systematic component: algorithm. The largest possible value Δ_s of the systematic component Δy_s can be obtained as follows:

- First, we apply the algorithm f to the measurement results $\tilde{x}_i(t_{ij})$ and get the estimate \tilde{y} .
- Then, we select a small value δ and for each sensor i , we do the following:
 - for this sensor i , we take $x_i^{(i)}(t_{ij}) = \tilde{x}_i(t_{ij}) + \delta$ for all moments j ;
 - for all other sensors $i' \neq i$, we take $x_{i'}^{(i)}(t_{i'j}) = \tilde{x}_{i'}(t_{i'j})$;
 - substitute the resulting values $x_{i'}^{(i)}(t_{i'j})$ into the data processing algorithm f and get the result $y^{(i)}$.
- Finally, we estimate the desired bound Δ_s on the systematic component Δy_s as

$$\Delta_s = \sum_i \left| \frac{y^{(i)} - \tilde{y}}{\delta} \right| \cdot \Delta_{si}.$$

Metrological comment. In some practical situations, instead of the *absolute* bound Δ_{si} on the systematic error of the i -th sensor, practitioners often describe *relative* accuracy δ_i such as 5% or 10%. In this case, a reasonable way to describe the absolute bound is to determine it as $\Delta_{si} = \delta_i \cdot a_i$, i.e., by multiplying the given value δ_i and the mean absolute value of the signal

$$a_i = \frac{1}{T_i} \cdot \sum_j |\tilde{x}_i(t_{ij})|.$$

Numerical example. Let us consider a simple case when we are estimating the difference between the average temperatures at two nearby locations. For example, we may be estimating the effect of a tree canopy on soil temperature, by comparing the temperature at a forest location with the temperature at a nearby clearance location. Alternatively, we can be estimating the effect of elevation of the temperature by comparing the temperatures at different elevations. In this case, we use the same frequency $\Delta t_1 = \Delta t_2$ for both sensors, so $t_{1j} = t_{2j} = t_j$. The difference in average temperatures is defined as

$$y = f(x_1(t_0), x_2(t_0), x_1(t_1), \dots, x_2(t_1), \dots, x_1(t_n), x_2(t_n)) =$$

$$\frac{x_1(t_0) + \dots + x_1(t_n)}{n+1} - \frac{x_2(t_0) + \dots + x_2(t_n)}{n+1}.$$

Let us assume that the known upper bound on the systematic error of the first sensor is $\Delta_{s1} = 0.1$, and the upper bound on the systematic error of the second sensor is $\Delta_{s2} = 0.2$. We perform measurements at three moments of time $t = 0, 1, 2$. During these three moments of time, the first sensor measured temperatures $\tilde{x}_1(t_0) = 20.0$, $\tilde{x}_1(t_1) = 21.9$, and $\tilde{x}_1(t_2) = 18.7$, and the second sensor measured temperatures $\tilde{x}_2(t_0) = 22.4$, $\tilde{x}_2(t_1) = 23.5$, and $\tilde{x}_2(t_2) = 21.0$. In this case, the estimate \tilde{y} for the desired difference y between average temperatures is equal to

$$\tilde{y} = \frac{20.0 + 21.9 + 18.7}{3} - \frac{22.4 + 23.5 + 21.0}{3} = 20.2 - 22.3 = -2.1.$$

According to our algorithm, we first select a small value δ , e.g., $\delta = 0.1$.

Then, we modify the results of the first sensor while keeping the results of the second sensor unchanged. As a result, we get $x_1^{(1)}(t_0) = \tilde{x}_1(t_0) + \delta = 20.0 + 0.1 = 20.1$, and similarly $x_1^{(1)}(t_1) = 22.0$ and $x_1^{(1)}(t_2) = 18.8$; we also get $x_2^{(1)}(t_0) = \tilde{x}_2(t_0) = 22.4$, and similarly $x_2^{(1)}(t_1) = 23.5$ and $x_2^{(1)}(t_2) = 21.0$. For thus modified values, we get

$$y^{(1)} = \frac{x_1^{(1)}(t_0) + x_1^{(1)}(t_1) + x_1^{(1)}(t_2)}{3} - \frac{x_2^{(1)}(t_0) + x_2^{(1)}(t_1) + x_2^{(1)}(t_2)}{3} =$$

$$\frac{20.1 + 22.0 + 18.8}{3} - \frac{22.4 + 23.5 + 21.0}{3} = 20.3 - 22.3 = -2.0.$$

Similarly, we modify the results of the second sensor while keeping the results of the first sensor unchanged. As a result, we get $x_1^{(2)}(t_0) = \tilde{x}_1(t_0) = 20.0$, and similarly $x_1^{(2)}(t_1) = 21.9$ and $x_1^{(2)}(t_2) = 18.7$; we also get $x_2^{(2)}(t_0) = \tilde{x}_2(t_0) + \delta = 22.4 + 0.1 = 22.5$, and similarly $x_2^{(2)}(t_1) = 23.6$ and $x_2^{(2)}(t_2) = 21.1$. For thus modified values, we get

$$y^{(2)} = \frac{x_1^{(2)}(t_0) + x_1^{(2)}(t_1) + x_1^{(2)}(t_2)}{3} - \frac{x_2^{(2)}(t_0) + x_2^{(2)}(t_1) + x_2^{(2)}(t_2)}{3} =$$

$$\frac{20.0 + 21.9 + 18.7}{3} - \frac{22.4 + 23.6 + 21.1}{3} = 20.2 - 22.4 = -2.2.$$

Finally, we estimate the desired bound Δ_s on the systematic component Δ_{sy} as

$$\Delta_s = \frac{|y^{(1)} - \tilde{y}|}{\delta} \cdot \Delta_{s1} + \frac{|y^{(2)} - \tilde{y}|}{\delta} \cdot \Delta_{s2} =$$

$$\frac{|(-2.0) - (-2.1)|}{0.1} \cdot 0.1 + \frac{|(-2.2) - (-2.1)|}{0.1} \cdot 0.3 = 1 \cdot 0.1 + 1 \cdot 0.3 = 0.4.$$

Finally, let us consider the problem of propagating the periodic components. By definition, the periodic-induced component $\Delta y_{p\ell}$ of the resulting error Δy is equal to

$$\Delta y_{p\ell} = \sum_i \sum_j C_{ij} \cdot A_{\ell i} \cdot \cos(\omega_\ell \cdot t_{ij} + \varphi_{\ell i}),$$

i.e., to

$$\Delta y_{p\ell} = \sum_i \sum_j C_{ij} \cdot A_{\ell i} \cdot (\cos(\omega_\ell \cdot t_{ij}) \cdot \cos(\varphi_{\ell i}) - \sin(\omega_\ell \cdot t_{ij}) \cdot \sin(\varphi_{\ell i})).$$

By combining the terms corresponding to different j , we conclude that

$$\Delta y_{p\ell} = \sum_i A_{\ell i} \cdot K_{ci} \cdot \cos(\varphi_{\ell i}) + \sum_i A_{\ell i} \cdot K_{si} \cdot \sin(\varphi_{\ell i}),$$

where $K_{ci} \stackrel{\text{def}}{=} \sum_j C_{ij} \cdot \cos(\omega_\ell \cdot t_{ij})$ and $K_{si} \stackrel{\text{def}}{=} \sum_j C_{ij} \cdot \sin(\omega_\ell \cdot t_{ij})$.

The values K_{ci} and K_{si} can be explicitly described. Namely:

- One can easily see that if for some small value $\delta > 0$, for this sensor i , we take $\Delta x_i(t_{ij}) = \delta \cdot \cos(\omega_\ell \cdot t_{ij})$ for all j , and for all other sensors i' , we take $\Delta x_{i'}(t_{i'j}) = 0$, then the resulting increase in y will be exactly equal to $\delta \cdot K_{ci}$.
- Similarly, if for this sensor i , we take $\Delta x_i(t_{ij}) = \delta \cdot \sin(\omega_\ell \cdot t_{ij})$ for all j , and for all other sensors i' , we take $\Delta x_{i'}(t_{i'j}) = 0$, then the resulting increase in y will be exactly equal to $\delta \cdot K_{si}$.

Once we have determined the coefficients K_{ci} and K_{si} , we need to describe the probability distribution of the sum $\Delta y_{p\ell} = \sum_i A_{\ell i} \cdot K_{ci} \cdot \cos(\varphi_{\ell i}) + \sum_i A_{\ell i} \cdot K_{si} \cdot \sin(\varphi_{\ell i})$.

We assumed that all φ_i are independent (and uniformly distributed). Thus, for the case of multiple sensors, we can apply the Central Limit Theorem and conclude that the distribution of the sum $\Delta y_{p\ell}$ is close to normal.

In general, normal distribution is uniquely determined by its first two moments: mean and variance (or, equivalently, standard deviation). The mean of each sine and cosine term is 0, so the mean of the sum $\Delta y_{p\ell}$ is zero as well. Since the terms corresponding to different sensors are independent, the variance of the sum is equal to the sum of the variances of individual terms. For each i , the mean of the square

$$(A_{\ell i} \cdot K_{ci} \cdot \cos(\varphi_{\ell i}) + A_{\ell i} \cdot K_{si} \cdot \sin(\varphi_{\ell i}))^2 =$$

$$A_{\ell i}^2 \cdot (K_{ci}^2 \cdot \cos^2(\varphi_{\ell i}) + K_{si}^2 \cdot \sin^2(\varphi_{\ell i}) + 2 \cdot K_{ci} \cdot K_{si} \cdot \cos(\varphi_{\ell i}) \cdot \sin(\varphi_{\ell i}))$$

is equal to $\frac{1}{2} \cdot A_{\ell i}^2 \cdot (K_{ci}^2 + K_{si}^2)$. Thus, the variance of the sum is equal to

$$\frac{1}{2} \cdot \sum_i A_{\ell i}^2 \cdot (K_{ci}^2 + K_{si}^2).$$

Each amplitude $A_{\ell i}$ can take any value from 0 to the known bound $P_{\ell i}$. The above expression monotonically increases with $A_{\ell i}$, and thus, it attains its largest value when $A_{\ell i}$ takes the largest value $P_{\ell i}$. Thus, the largest possible value of the variance is equal to $\frac{1}{2} \cdot \sum_i P_{\ell i}^2 \cdot (K_{ci}^2 + K_{si}^2)$.

Thus, we arrive at the following algorithm for computing the upper bound $\sigma_{p\ell}$ of the standard deviation of the periodic-induced component $\Delta y_{p\ell}$ on the approximation error Δy .

Propagating periodic-induced component: algorithm. The upper bound $\sigma_{p\ell}$ on the standard deviation of the periodic-induced component $\Delta y_{p\ell}$ can be obtained as follows:

- First, we apply the algorithm f to the measurement results $\tilde{x}_i(t_{ij})$ and get the estimate \tilde{y} .
- Then, we select a small value δ and for each sensor i , we do the following:
 - for this sensor i , we take $x_i^{(ci)}(t_{ij}) = \tilde{x}_i(t_{ij}) + \delta \cdot \cos(\omega_\ell \cdot t_{ij})$ for all moments j ;
 - for all other sensors $i' \neq i$, we take $x_{i'}^{(ci)}(t_{i'j}) = \tilde{x}_{i'}(t_{i'j})$;
 - substitute the resulting values $x_{i'}^{(ci)}(t_{i'j})$ into the data processing algorithm f and get the result $y^{(ci)}$;
 - then, for this sensor i , we take $x_i^{(si)}(t_{ij}) = \tilde{x}_i(t_{ij}) + \delta \cdot \sin(\omega_\ell \cdot t_{ij})$ for all moments j ;
 - for all other sensors $i' \neq i$, we take $x_{i'}^{(si)}(t_{i'j}) = \tilde{x}_{i'}(t_{i'j})$;
 - substitute the resulting values $x_{i'}^{(si)}(t_{i'j})$ into the data processing algorithm f and get the result $y^{(si)}$.
- Finally, we estimate the desired bound $\sigma_{p\ell}$ as

$$\sigma_{p\ell} = \sqrt{\frac{1}{2} \cdot \sum_i P_{\ell i}^2 \cdot \left(\left(\frac{y^{(ci)} - \tilde{y}}{\delta} \right)^2 + \left(\frac{y^{(si)} - \tilde{y}}{\delta} \right)^2 \right)}.$$

Metrological comment. In some practical situations, instead of the *absolute* bound $P_{\ell i}$ on the amplitude of the corresponding periodic error components, practitioners often describe *relative* accuracy $\delta_{\ell i}$ such as 5% or 10%. In this case, a reasonable way to describe the absolute bound is to determine it as $\sigma_i = \delta_i \cdot m_i$, i.e., by multiplying the given value δ_i and the mean square value of the signal

$$m_i = \sqrt{\frac{1}{T_i} \cdot \sum_j (\tilde{x}_i(t_{ij}))^2}.$$

Example. To test our algorithm, we have applied it to compute the corresponding error component in the problem of estimating carbon and water fluxes described

in the paper [14], where such the notion of a periodic error component was first introduced. Our numerical results are comparable with the conclusions of that paper. In the future, we plan to apply all the above algorithms to the results obtained by the sensors on the Jornada Experimental Range Eddy covariance tower and on the nearby robotic tram, and by the affiliated stationary sensors [5, 6, 7, 8, 11, 17].

8 Conclusion

In many application areas, it is necessary to process time series. In this processing, it is necessary to take into account uncertainty with which we know the corresponding values. Traditionally, measurement uncertainty has been classified into systematic and random components. However, for time series, this classification is often not sufficient, especially in the analysis of seasonal meteorological and environmental time series. To describe real-life measurement uncertainty more accurately, researchers have come up with a semi-empirical idea of introducing a new type of measurement uncertainty – that corresponds to periodic errors. In this paper, we provide a mathematical justification for this new error component, and describe efficient algorithms for propagating the resulting three-component uncertainty.

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